

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/083,920	NIERENBERG, ALAN B.	
Examiner	Ljiljana (Lil) V. Ciric <i>JK</i>	Art Unit	3753	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,598,408 B1	07-2003	Nierenberg, Alan B.	62/50.2
*	B	US-6,688,114 B2	02-2004	Nierenberg, Alan B.	62/50.2
*	C	US-3,986,340	10-1976	Bivins, Jr., Henry W.	62/50.2
*	D	US-3,986,340	10-1976	Bivins, Jr., Henry W.	62/50.2
*	E	US-4,231,226	11-1980	Griepentrog, Hartmut	62/50.2
*	F	US-6,250,244	06-2001	Dubar et al.	62/613
*	G	US-6,367,429 B2	04-2002	Iwasaki et al.	62/50.2
*	H	US-6,546,739 B2	04-2003	Frimm et al.	62/50.2
*	I	US-6,832,875 B2	12-2004	Bliault et al.	405/195.1
*	J	US-2002/0073619 A1	06-2002	Perkins et al.	48/190
*	K	US-2003/0182948 A1	10-2003	Nierenberg, Alan B.	62/50.2
*	L	US-2005/0061002 A1	03-2005	Nierenberg, Alan	060/670
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.